

**Notice of References Cited**

Application/Control No.

10/697,533

Applicant(s)/Patent Under  
Reexamination  
RUNDLE ET AL.

Examiner

Bernard Krasnic

Art Unit

2621

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,292,709	09-2001	Uhl et al.	700/226
*	B	US-5,515,455	05-1996	Govindaraju et al.	382/186
*	C	US-2002/0141613 A1	10-2002	Sansone, Ronald P.	382/101
*	D	US-7,024,019 B2	04-2006	Sansone, Ronald P.	382/101
*	E	US-6,567,008 B1	05-2003	Sansone, Ronald P.	340/666
*	F	US-6,778,683 B1	08-2004	Bonner et al.	382/101
*	G	US-2002/0029202 A1	03-2002	Lopez, Steven W.	705/406
*	H	US-6,025,931	02-2000	Bloomfield, Mark C	358/402
*	I	US-7,071,437 B2	07-2006	Ryan et al.	209/584
*	J	US-6,246,794 B1	06-2001	Kagehiro et al.	382/185
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003085301 A	03-2003	Japan	HIRABAYASHI, MAKOTO	G06F 017/60
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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